

UPA2201T1M-T2-AT-VB Datasheet

N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY

V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A)	Q_g (TYP.)
30	0.016 at $V_{GS} = 10$ V	9	9 nC
	0.019 at $V_{GS} = 4.5$ V	8	

FEATURES

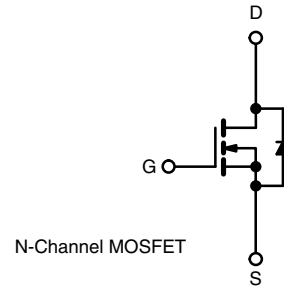
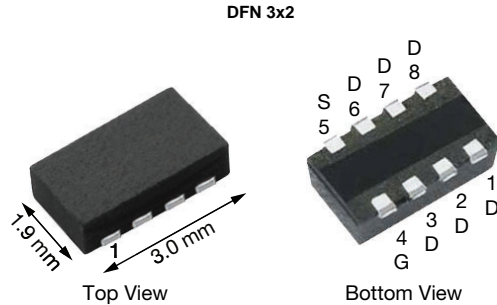
- Trench power MOSFET

APPLICATIONS

- Load switches
- Notebook PC



RoHS
 COMPLIANT
 HALOGEN
FREE

**ABSOLUTE MAXIMUM RATINGS** ($T_A = 25$ °C, unless otherwise noted)

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current ($T_J = 150$ °C)	$T_C = 25$ °C	I_D	9	A
	$T_C = 70$ °C		6 ^a	
	$T_A = 25$ °C		6 ^{a, b, c}	
	$T_A = 70$ °C		6 ^{a, b, c}	
Pulsed Drain Current		I_{DM}	30	A
Continuous Source-Drain Diode Current	$T_C = 25$ °C	I_S	5.2	
	$T_A = 25$ °C		2.1 ^{b, c}	
Maximum Power Dissipation	$T_C = 25$ °C	P_D	6.3	W
	$T_C = 70$ °C		4	
	$T_A = 25$ °C		2.5 ^{b, c}	
	$T_A = 70$ °C		1.6 ^{b, c}	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	-55 to +150	°C
Soldering Recommendations (Peak Temperature) ^{e, f}			260	

THERMAL RESISTANCE RATINGS

PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT
Maximum Junction-to-Ambient ^{a, c, d}	$t \leq 5$ s	R_{thJA}	40	50	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	15	20	

Notes

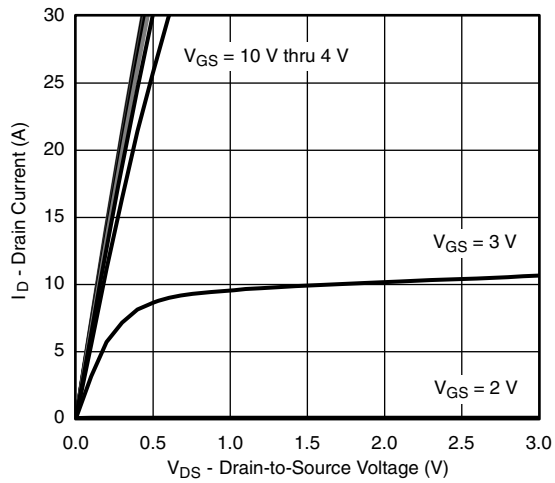
- Package limited, $T_C = 25$ °C.
- Surface mounted on 1" x 1" FR4 board.
- $t = 10$ s
- Maximum under steady state conditions is 95 °C/W.
- The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30	-	-	V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = 250 μA	-	31	-	mV/°C	
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J		-	-5.1	-		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1.2	-	2.5	V	
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V	-	-	± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V	-	-	1	μA	
		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C	-	-	5		
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	20	-	-	A	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 9.1 A	-	0.016	-	Ω	
		V _{GS} = 4.5 V, I _D = 8.1 A	-	0.019	-		
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 9.1 A	-	30	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	-	1200	-	pF	
Output Capacitance	C _{oss}		-	180	-		
Reverse Transfer Capacitance	C _{rss}		-	80	-		
Total Gate Charge	Q _g	V _{DS} = 10 V, V _{GS} = 10 V, I _D = 9.1 A	-	19	29	nC	
		V _{DS} = 10 V, V _{GS} = 4.5 V, I _D = 9.1 A	-	9	14		
Q _{gs}	-		3.5	-			
Q _{gd}	-		2.3	-			
Gate Resistance	R _g	f = 1 MHz	-	3	-	Ω	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 15 V, R _L = 2.1 Ω I _D ≅ 7.3 A, V _{GEN} = 4.5 V, R _g = 1 Ω	-	20	30	ns	
Rise Time	t _r		-	12	20		
Turn-Off Delay Time	t _{d(off)}		-	20	30		
Fall Time	t _f		-	10	15		
Turn-On Delay Time	t _{d(on)}	V _{DD} = 15 V, R _L = 2.1 Ω I _D ≅ 7.3 A, V _{GEN} = 10 V, R _g = 1 Ω	-	10	15		
Rise Time	t _r		-	10	15		
Turn-Off Delay Time	t _{d(off)}		-	20	30		
Fall Time	t _f		-	10	15		
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	-	-	5.2	A	
Pulse Diode Forward Current	I _{SM}		-	-	30		
Body Diode Voltage	V _{SD}	I _S = 7.3 A, V _{GS} = 0 V	-	0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	I _F = 7.3 A, dI/dt = 100 A/μs, T _J = 25 °C	-	20	40	ns	
Body Diode Reverse Recovery Charge	Q _{rr}		-	10	20	nC	
Reverse Recovery Fall Time	t _a		-	11	-	ns	
Reverse Recovery Rise Time	t _b		-	9	-		

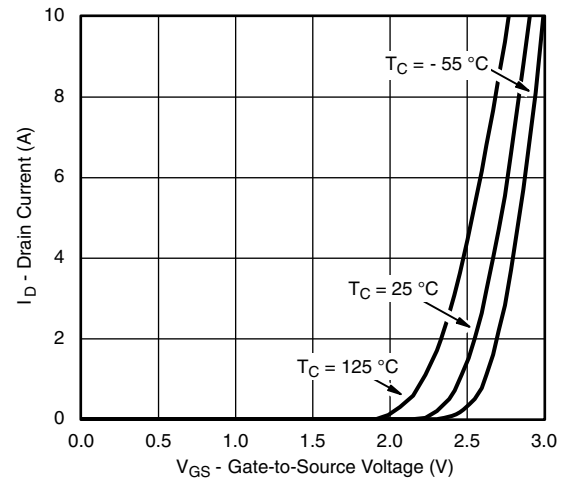
Notes

- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
 b. Guaranteed by design, not subject to production testing.

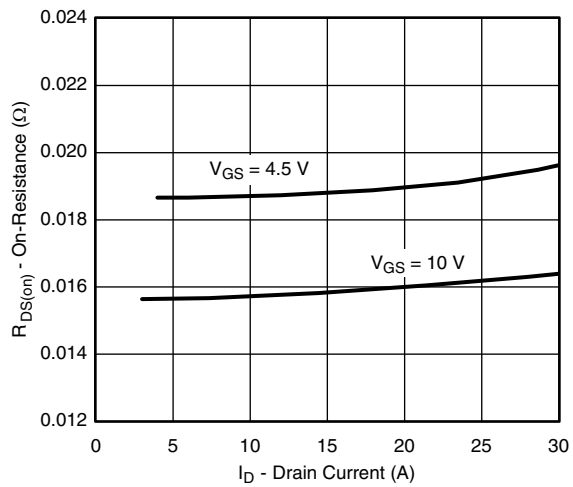
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)


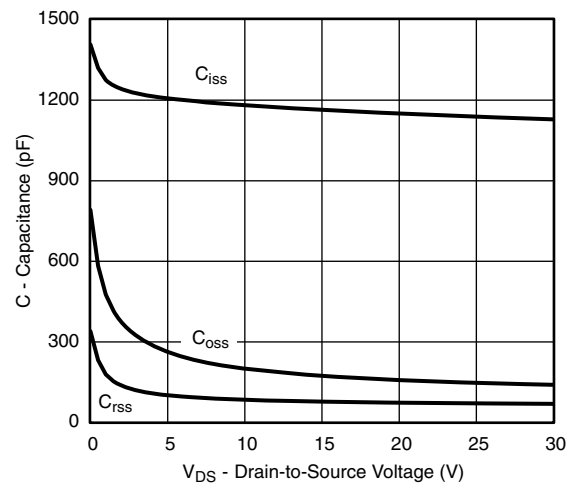
Output Characteristics



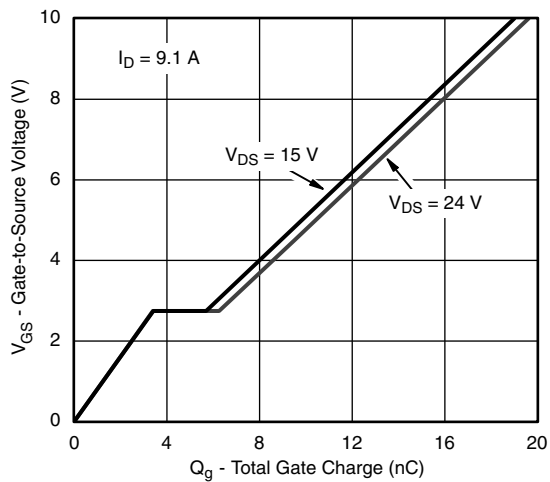
Transfer Characteristics



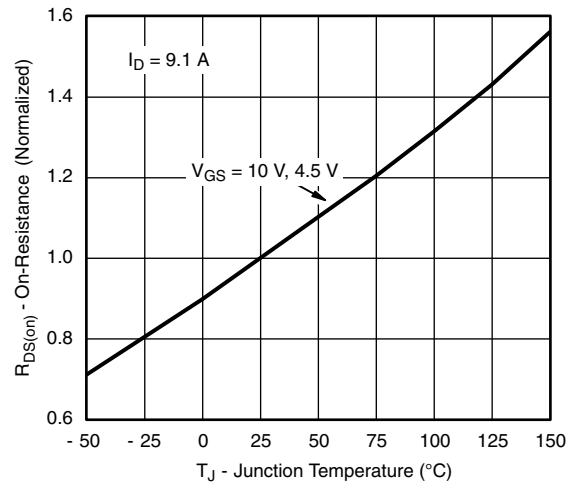
On-Resistance vs. Drain Current



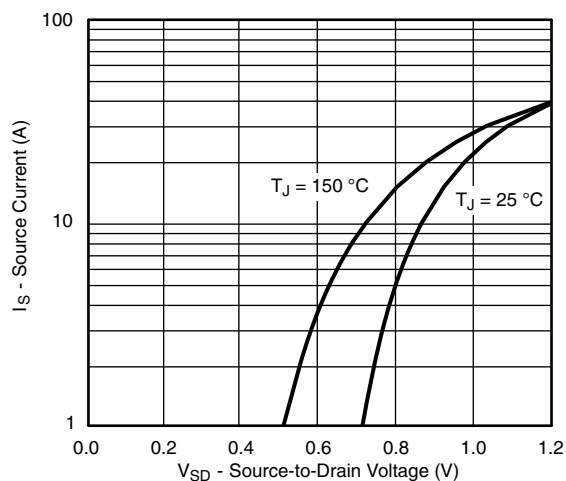
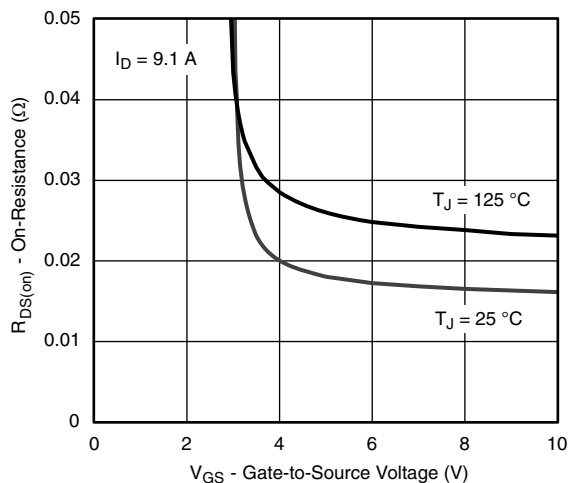
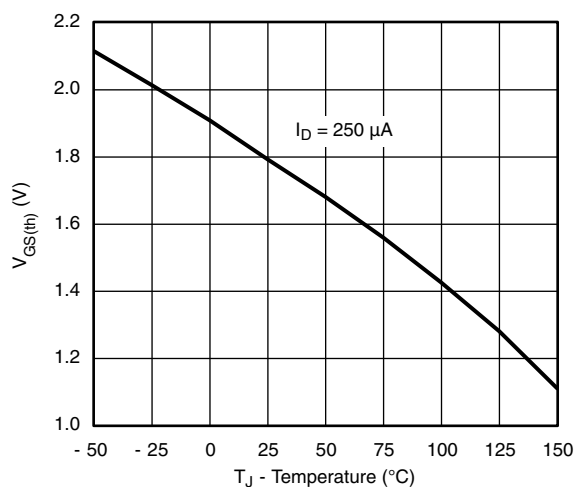
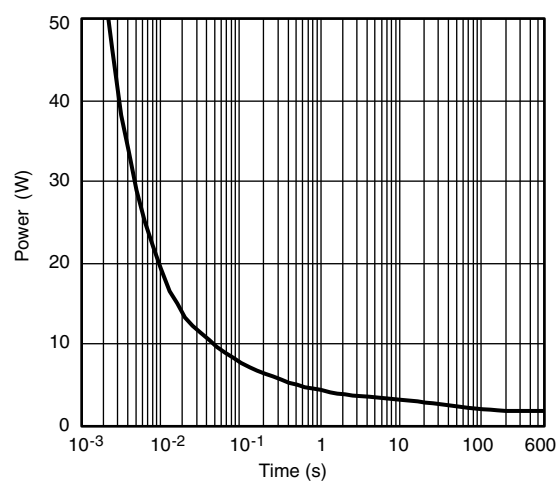
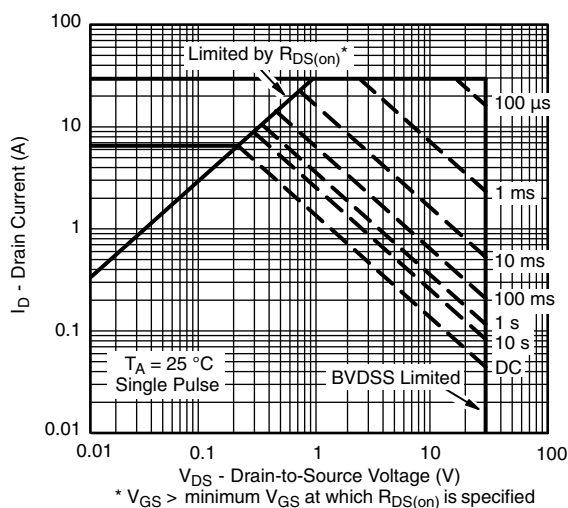
Capacitance

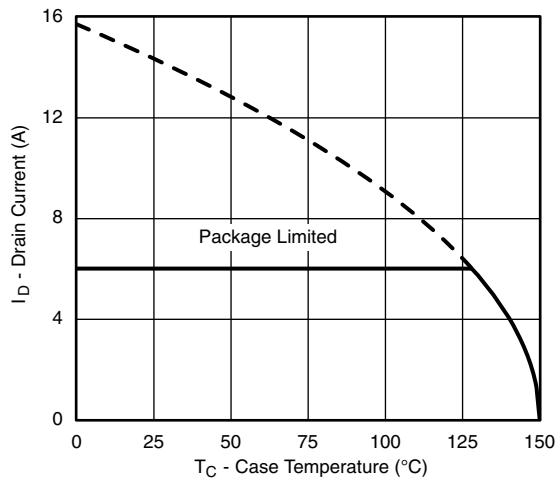
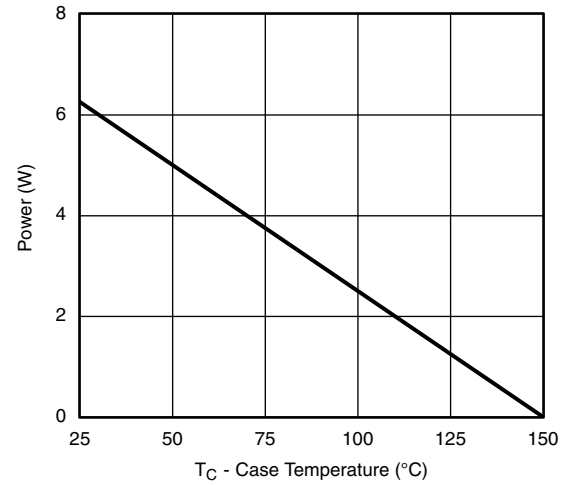


Gate Charge

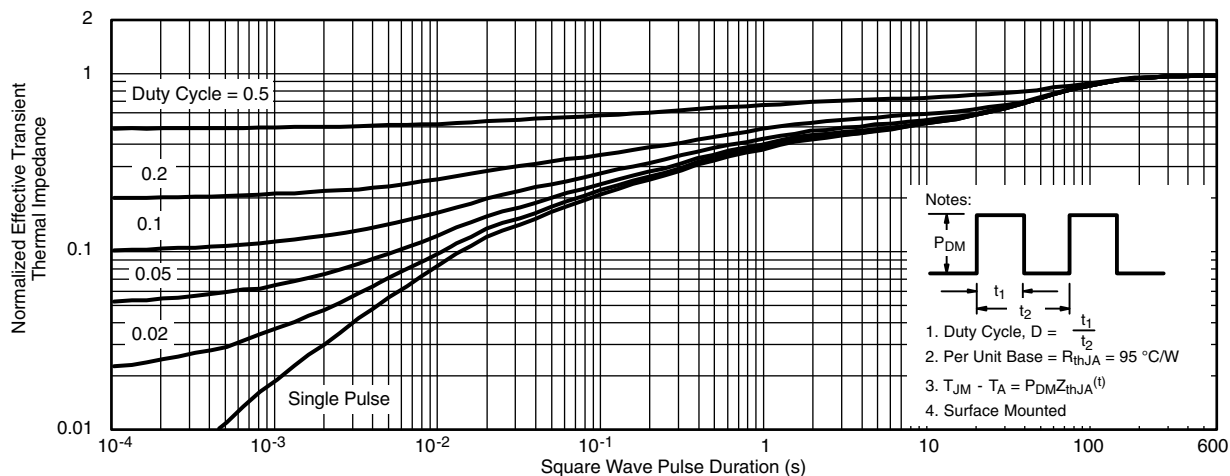
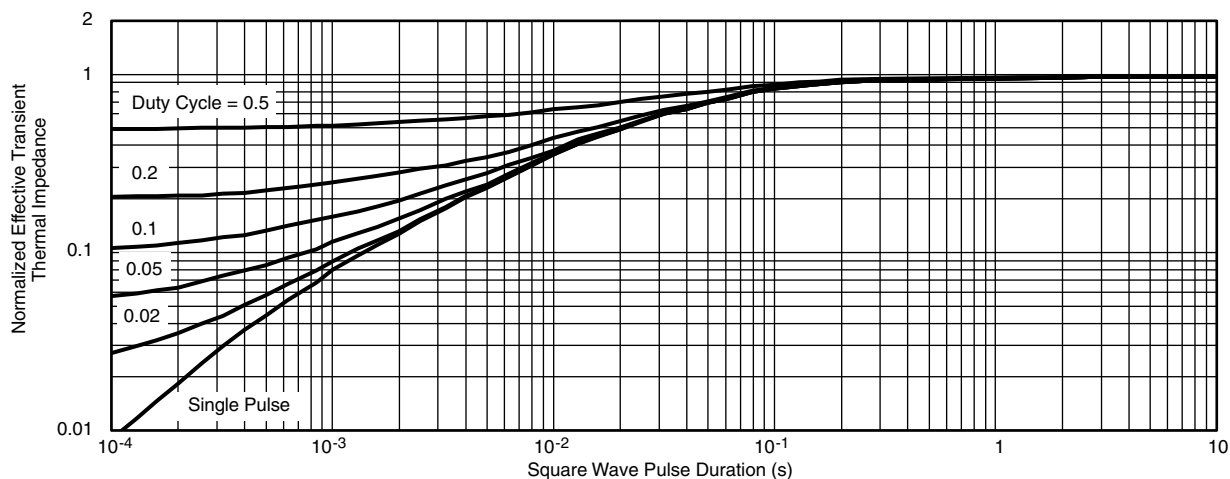


On-Resistance vs. Junction Temperature

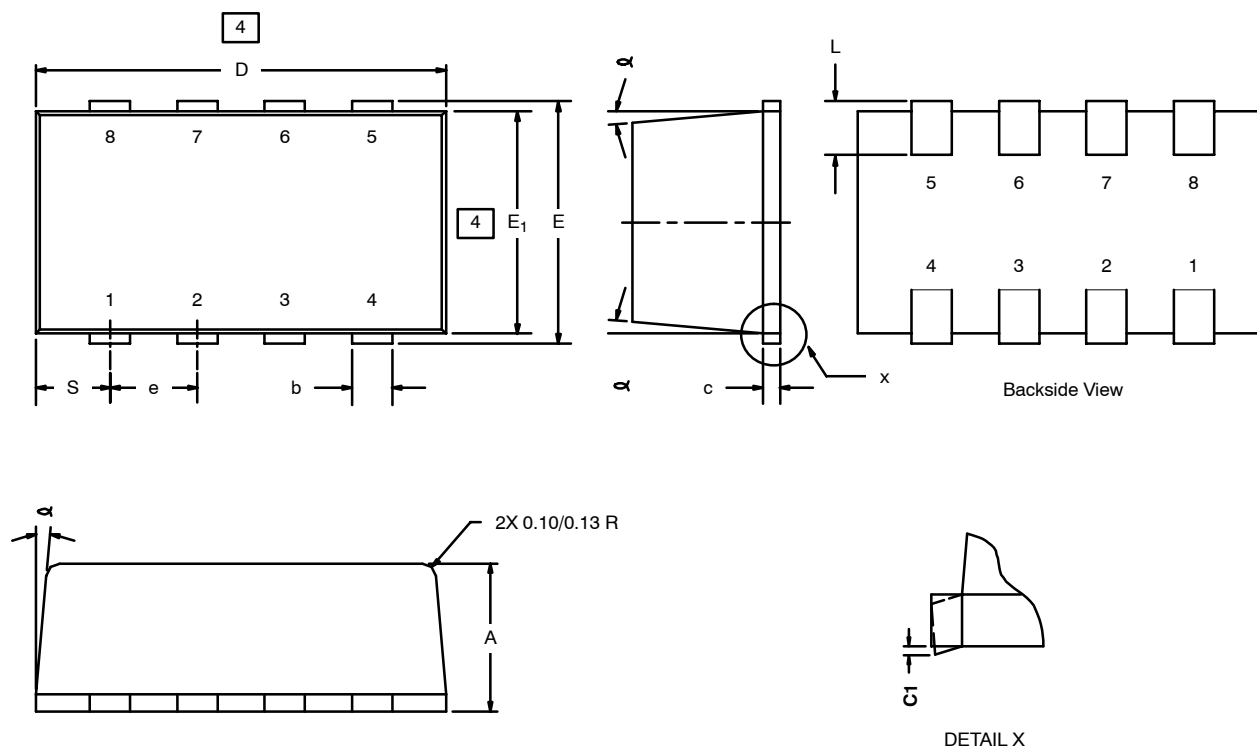
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

Threshold Voltage

Single Pulse Power

Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)**Current Derating ^a****Power Derating****Note**

- a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

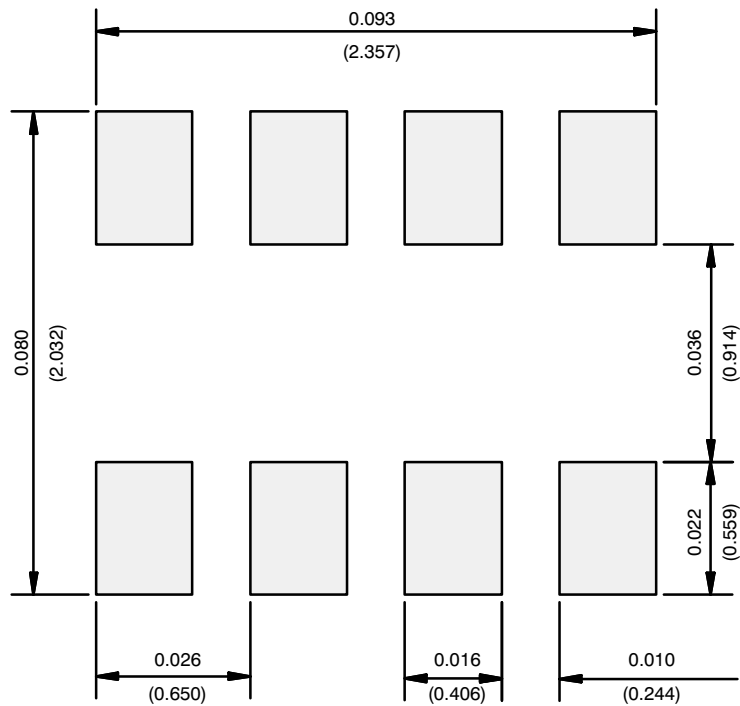
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Normalized Thermal Transient Impedance, Junction-to-Ambient

Normalized Thermal Transient Impedance, Junction-to-Foot

DFN 3x2



	MILLIMETERS			INCHES		
Dim	Min	Nom	Max	Min	Nom	Max
A	1.00	–	1.10	0.039	–	0.043
b	0.25	0.30	0.35	0.010	0.012	0.014
c	0.1	0.15	0.20	0.004	0.006	0.008
c1	0	–	0.038	0	–	0.0015
D	2.95	3.05	3.10	0.116	0.120	0.122
E	1.825	1.90	1.975	0.072	0.075	0.078
E ₁	1.55	1.65	1.70	0.061	0.065	0.067
e	0.65 BSC			0.0256 BSC		
L	0.28	–	0.42	0.011	–	0.017
S	0.55 BSC			0.022 BSC		
α	5°Nom			5°Nom		
ECN: C-03528—Rev. F, 19-Jan-04						
DWG: 5547						

RECOMMENDED MINIMUM PADS FOR DFN3x2



Recommended Minimum Pads
Dimensions in Inches/(mm)

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